

smartctl 5.43 2012-06-30 r3573 [FreeBSD 8.3-RELEASE-p5 amd64] (local build)  
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=== START OF INFORMATION SECTION ===

Device Model: TOSHIBA DT01ACA100  
Serial Number: Y2HNSU0FS  
LU WWN Device Id: 5 000039 ff2c970ca  
Firmware Version: MS20A750  
User Capacity: 1,000,204,886,016 bytes [1.00 TB]  
Sector Sizes: 512 bytes logical, 4096 bytes physical  
Device is: Not in smartctl database [for details use: -P showall]  
ATA Version is: 8  
ATA Standard is: ATA-8-ACS revision 4  
Local Time is: Mon Oct 21 20:24:30 2013 CEST  
SMART support is: Available - device has SMART capability.  
SMART support is: Enabled

=== START OF READ SMART DATA SECTION ===

SMART overall-health self-assessment test result: PASSED

General SMART Values:

Offline data collection status: (0x80) Offline data collection activity  
was never started.

Auto Offline Data Collection:

Enabled.

Self-test execution status: ( 0) The previous self-test routine  
completed

without error or no self-test has

ever

been run.

Total time to complete Offline  
data collection: ( 7313) seconds.

Offline data collection  
capabilities:

(0x5b) SMART execute Offline immediate.

Auto Offline data collection on/off

support.

Suspend Offline collection upon new  
command.

Offline surface scan supported.

Self-test supported.

No Conveyance Self-test supported.

Selective Self-test supported.

SMART capabilities: (0x0003) Saves SMART data before entering  
power-saving mode.

Supports SMART auto save timer.

Error logging capability: (0x01) Error logging supported.

General Purpose Logging supported.

Short self-test routine  
recommended polling time: ( 1) minutes.

Extended self-test routine

```
recommended polling time:      ( 122) minutes.
SCT capabilities:              (0x003d) SCT Status supported.
                                SCT Error Recovery Control
supported.
                                SCT Feature Control supported.
                                SCT Data Table supported.
```

SMART Attributes Data Structure revision number: 16

### Vendor Specific SMART Attributes with Thresholds:

ID#	ATTRIBUTE_NAME	FLAG	VALUE	WORST	THRESH	TYPE	UPDATED
1	Raw_Read_Error_Rate	0x000b	100	100	016	Pre-fail	Always
-	0						
2	Throughput_Performance	0x0005	141	141	054	Pre-fail	Offline
-	72						
3	Spin_Up_Time	0x0007	126	126	024	Pre-fail	Always
-	184 (Average 179)						
4	Start_Stop_Count	0x0012	100	100	000	Old_age	Always
-	89						
5	Reallocated_Sector_Ct	0x0033	100	100	005	Pre-fail	Always
-	59						
7	Seek_Error_Rate	0x000b	100	100	067	Pre-fail	Always
-	0						
8	Seek_Time_Performance	0x0005	118	118	020	Pre-fail	Offline
-	33						
9	Power_On_Hours	0x0012	100	100	000	Old_age	Always
-	257						
10	Spin_Retry_Count	0x0013	100	100	060	Pre-fail	Always
-	0						
12	Power_Cycle_Count	0x0032	100	100	000	Old_age	Always
-	87						
192	Power-Off_Retract_Count	0x0032	100	100	000	Old_age	Always
-	385						
193	Load_Cycle_Count	0x0012	100	100	000	Old_age	Always
-	385						
194	Temperature_Celsius	0x0002	214	214	000	Old_age	Always
-	28 (Min/Max 17/42)						
196	Reallocated_Event_Count	0x0032	097	097	000	Old_age	Always
-	219						
197	Current_Pending_Sector	0x0022	100	100	000	Old_age	Always
-	0						
198	Offline_Uncorrectable	0x0008	100	100	000	Old_age	Offline
-	0						
199	UDMA_CRC_Error_Count	0x000a	200	200	000	Old_age	Always
-	0						

SMART Error Log Version: 1

No Errors Logged

SMART Self-test log structure revision number 1

No self-tests have been logged. [To run self-tests, use: smartctl -t]

SMART Selective self-test log data structure revision number 1

SPAN	MIN_LBA	MAX_LBA	CURRENT_TEST_STATUS
1	0	0	Not_testing
2	0	0	Not_testing
3	0	0	Not_testing
4	0	0	Not_testing
5	0	0	Not_testing

Selective self-test flags (0x0):

After scanning selected spans, do NOT read-scan remainder of disk.

If Selective self-test is pending on power-up, resume after 0 minute delay.